

# NPN 4 GHz wideband transistor

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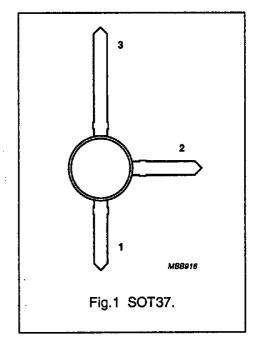
#### **DESCRIPTION**

NPN transistor in a plastic SOT37 envelope, intended for wideband amplification applications. The device features high output voltage capabilities.

A SOT5 (TO-39) version (ref: ON4497) is available on request.

#### **PINNING**

PIN	DESCRIPTION
1	base
2	emitter
3	collector



#### **QUICK REFERENCE DATA**

SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.	MAX.	UNIT
V <sub>CBO</sub>	collector-base voltage	open emitter	-	-	25	٧
V <sub>CEO</sub>	collector-emitter voltage	open base	-	_	18	٧
l <sub>c</sub>	collector current		-	-	150	mA
P <sub>tot</sub>	total power dissipation	up to T <sub>s</sub> = 145 °C (note 1)	-	-	1	W
h <sub>FE</sub>	DC current gain	I <sub>C</sub> = 100 mA; V <sub>CE</sub> = 10 V; T <sub>j</sub> = 25 °C	25	70	-	
f <sub>T</sub> www.DataSl	transition frequency eet4U.com	I <sub>C</sub> = 100 mA; V <sub>CE</sub> = 10 V; f = 800 MHz; T <sub>i</sub> = 25 °C	-	3.7	-	GHz
G <sub>um</sub>	maximum unilateral power gain	I <sub>C</sub> = 100 mA; V <sub>CE</sub> = 10 V; f = 800 MHz; T <sub>amb</sub> = 25 °C	_	12	_	dB
V <sub>o</sub>	output voltage	$d_{im} = -60 \text{ dB}; I_C = 90 \text{ mA}; V_{CE} = 10 \text{ V};$ $R_L = 75 \Omega; T_{amb} = 25 \text{ °C};$ $f_{(p+q-r)} = 793.25 \text{ MHz}$	-	750	_	mV
P <sub>L1</sub>	output power at 1 dB gain compression	$V_{CE} = 10 \text{ V; } I_{C} = 90 \text{ mA; } f = 800 \text{ MHz;}$ $T_{amb} = 25 \text{ °C}$	-	22		dBm
ITO	third order intercept point	$I_C = 90 \text{ mA}; V_{CE} = 10 \text{ V}; f = 800 \text{ MHz};$ $T_{amb} = 25 \text{ °C}$	_	41	_	dBm

### Note

1. T<sub>s</sub> is the temperature at the soldering point of the collector lead.

APX Product specification

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#### **LIMITING VALUES**

In accordance with the Absolute Maximum System (IEC 134).

SYMBOL	PARAMETER	CONDITIONS	MIN.	MAX.	UNIT	
V <sub>CBO</sub>	collector-base voltage	open emitter	_	25	٧	
V <sub>CEO</sub>	collector-emitter voltage	open base	<u> </u>	18	٧	
VEBO	emitter-base voltage	open collector	_	2	٧	
l <sub>c</sub>	DC collector current		-	150	mA	
P <sub>tot</sub>	total power dissipation	up to T <sub>s</sub> = 145 °C (note 1)	-	1	W	
T <sub>stg</sub>	storage temperature		-65	150	°C	
T <sub>i</sub>	junction temperature		_	175	°C	

#### THERMAL RESISTANCE

SYMBOL	PARAMETER	CONDITIONS	THERMAL RESISTANCE
R <sub>th j-s</sub>	thermal resistance from junction to soldering point	up to T <sub>e</sub> = 145 °C (note 1)	30 K/W

#### Note

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#### **CHARACTERISTICS**

 $T_i = 25$  °C unless otherwise specified.

SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.	MAX.	UNIT	
I <sub>CBO</sub>	collector cut-off current	I <sub>E</sub> = 0; V <sub>CB</sub> = 15 V	-	-	100	μА	
h <sub>FE</sub>	DC current gain	I <sub>C</sub> = 100 mA; V <sub>CE</sub> = 10 V	25	70	_		
f <sub>T</sub>	transition frequency	I <sub>C</sub> = 100 mA; V <sub>CE</sub> = 10 V; f = 800 MHz	_	3.7	-	GHz	
C <sub>c</sub>	collector capacitance	$I_E = I_e = 0$ ; $V_{CB} = 10 \text{ V}$ ; $f = 1 \text{ MHz}$	-	2	<u> </u>	pF	
C <sub>e</sub>	emitter capacitance	$I_{c} = I_{c} = 0; V_{EB} = 0.5 \text{ V}; f = 1 \text{ MHz}$	-	10	-	pF	
C <sub>re</sub>	feedback capacitance	I <sub>C</sub> = 0; V <sub>CE</sub> = 10 V; f = 1 MHz	_	1.2	-	pF	
G <sub>UM</sub>	maximum unilateral power gain (note 1)	I <sub>C</sub> = 100 mA; V <sub>CE</sub> = 10 V; f = 800 MHz; T <sub>amb</sub> = 25 °C	-	12	_	dB	
d <sub>2</sub>	second order intermodulation distortion (Fig.2)	note 2	_	-55	-	dB	
V <sub>o</sub>	output voltage	note 3	-	1	-	٧	
		note 4	_	750	-	mV	
P <sub>L1</sub>	output power at 1 dB gain compression	$I_C$ = 90 mA; $V_{CE}$ = 10 V; $T_{amb}$ = 25 °C; measured at f = 800 MHz	_	22	_	dBm	
ITO	third order intercept point	$I_{C} = 90 \text{ mA}; V_{CE} = 10 \text{ V}; f = 500 \text{ MHz};$ $T_{amb} = 25 \text{ °C}$	-	41	-	dBm	

#### **Notes**

- 1.  $G_{UM}$  is the maximum unilateral power gain, assuming  $S_{12}$  is zero and  $G_{UM} = 10 \log \frac{|S_{21}|^2}{(1 |S_{12}|^2)(1 |S_{22}|^2)}$  dB.
- 2.  $I_C = 60 \text{ mA}$ ;  $V_{CE} = 10 \text{ V}$ ;  $R_L = 75 \Omega$ ;  $T_{amb} = 25 ^{\circ}\text{C}$ ;  $V_{o} = V_{p} = V_{O} = 48 \text{ dBmV}; f_{p} = 560 \text{ MHz};$ wwV\_p=366=50 dBmV;  $f_q = 250$  MHz;

measured at  $f_{(p+q)} = 810$  MHz.

3.  $d_{im} = -60 \text{ dB (DIN 45004B)}$ ;  $l_{c} = 100 \text{ mA}$ ;  $V_{CE} = 10 \text{ V}$ ;  $R_{L} = 75 \Omega$ ;  $T_{amb} = 25 ^{\circ}\text{C}$ ;

 $V_p = V_O$  at  $d_{im} = -60$  dB;  $f_p = 287.25$  MHz;

 $V_q = V_O - 6 \text{ dB}$ ;  $f_q = 294.25 \text{ MHz}$ ;

 $V_r = V_O - 6 \text{ dB}$ ;  $f_r = 295.25 \text{ MHz}$ ;

measured at  $f_{(p+q-r)} = 285.25$  MHz.

4.  $d_{im} = -60 \text{ dB (DIN 45004B)}$ ;  $I_C = 90 \text{ mA}$ ;  $V_{CE} = 10 \text{ V}$ ;  $R_L = 75 \Omega$ ;  $T_{amb} = 25 ^{\circ}\text{C}$ ;

 $V_p = V_O$  at  $d_{im} = -60$  dB;  $f_p = 797.25$  MHz;

 $V_a = V_O - 6 \text{ dB}$ ;  $f_a = 803.25 \text{ MHz}$ ;

 $V_r = V_O - 6 \text{ dB}$ ;  $f_r = 805.25 \text{ MHz}$ ;

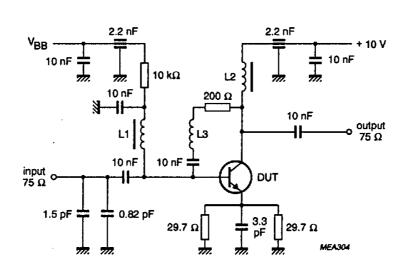
measured at  $f_{(p+q-r)} = 793.25$  MHz.

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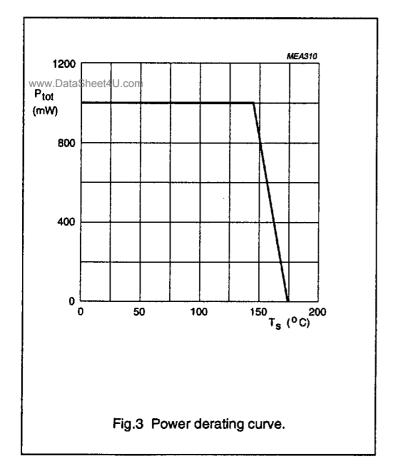
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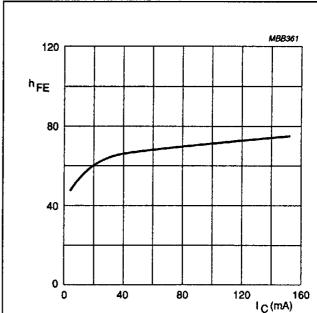


 $L1 = L2 = 5 \mu H$  Ferroxcube choke.

L3 = 2 turns 0.5 mm copper wire; winding pitch 2 mm; internal diameter 4 mm.

Fig.2 Intermodulation distortion and second order intermodulation distortion MATV test circuit.





 $V_{CE} = 10 \text{ V}; T_i = 25 \,^{\circ}\text{C}.$ 

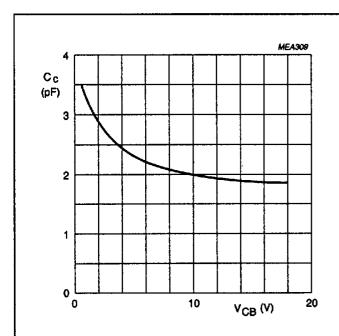
Fig.4 DC current gain as a function of collector current.

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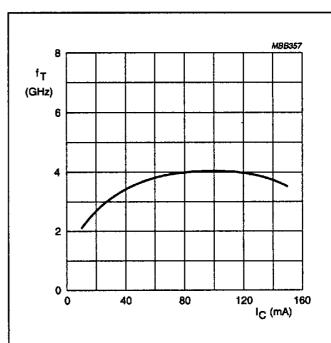
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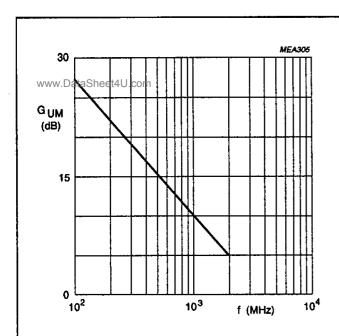
 $I_E = 0$ ; f = 1 MHz;  $T_i = 25$  °C.

Fig.5 Collector capacitance as a function of collector-base voltage.



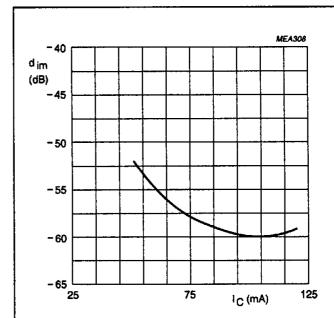
 $V_{CE} = 10 \text{ V; } f = 800 \text{ MHz; } T_j = 25 \text{ °C}.$ 

Fig.6 Transition frequency as a function of collector current.



 $I_C = 100$  mA;  $V_{CE} = 10$  V;  $T_{amb} = 25$  °C.

Fig.7 Maximum unilateral power gain as a function of frequency.



 $V_{CE} = 10 \text{ V}; V_{O} = 750 \text{ mV}; T_{amb} = 25 \,^{\circ}\text{C}; f_{(p+q-r)} = 793.25 \text{ MHz}.$ 

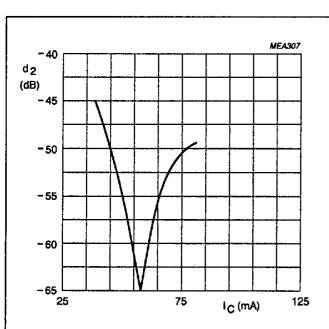
Fig.8 Intermodulation distortion as a function of collector current.

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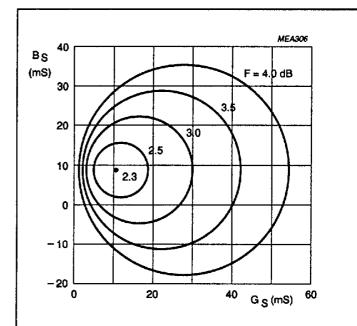
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 $V_{CE}$  = 10 V;  $V_{O}$  = 48 dBmV;  $T_{amb}$  = 25 °C;  $f_{p}$  = 560 MHz;  $f_{q}$  = 250 MHz;  $f_{(p+q)}$  = 810 MHz.

Fig.9 Second order intermodulation distortion as a function of collector current.



 $I_C = 20$  mA;  $V_{CE} = 10$  V; f = 800 MHz;  $T_{amb} = 25$  °C.

Fig.10 Noise circle figure.

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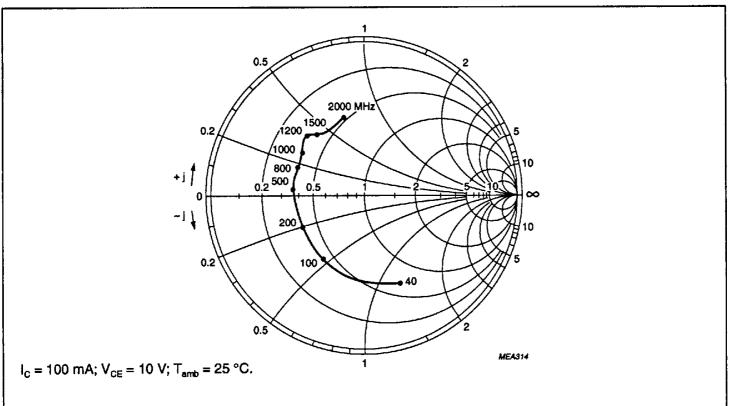
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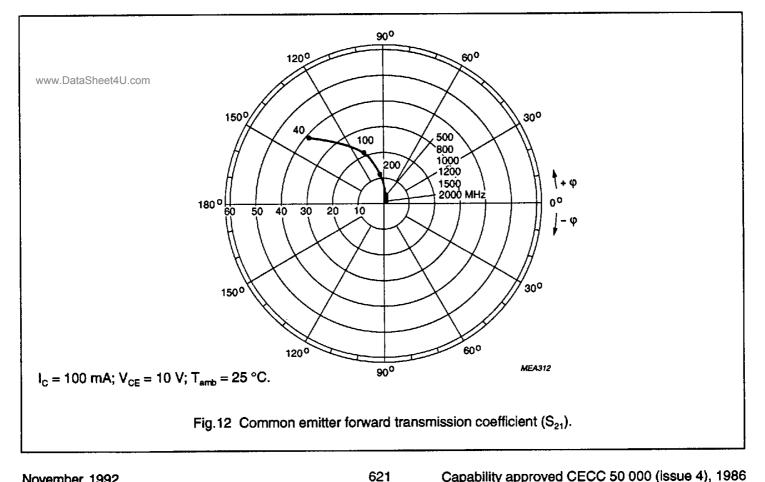
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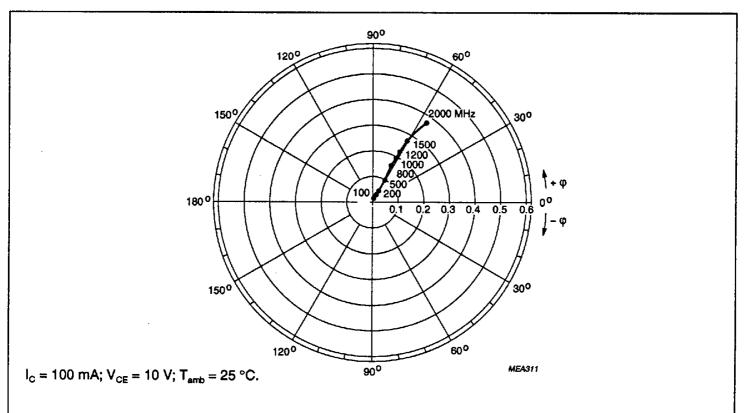
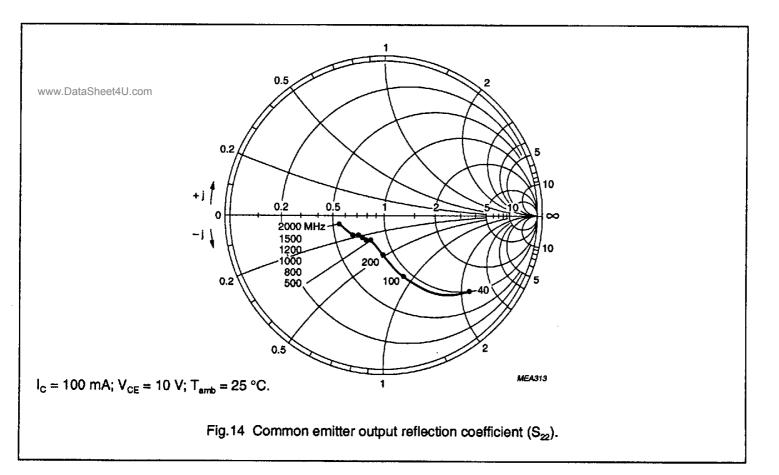


Fig.13 Common emitter reverse transmission coefficient (S<sub>12</sub>).



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**Table 1** Common emitter scattering parameters,  $I_C = 70$  mA;  $V_{CE} = 10$  V

	s	11	S	21	s	12	s	22	G
T (MHz)	MAG. (RAT)	ANG. (DEG)	MAG. (RAT)	ANG. (DEG)	MAG. (RAT)	ANG. (DEG)	MAG. (RAT)	ANG. (DEG)	G <sub>UM</sub> (dB)
40	0.459	-73.8	32.733	142.7	0.019	65.0	0.801	-35.7	35.8
100	0.469	-126.0	19.677	116.6	0.033	56.9	0.500	-61.7	28.2
200	0.479	-156.6	10.977	98.5	0.048	58.6	0.307	-78.8	22.4
300	0.483	-171.9	7.424	89.5	0.063	61.8	0.241	-88.2	18.8
400	0.507	179.1	5.674	82.8	0.078	64.1	0.216	-94.6	16.6
500	0.507	172.8	4.597	77.4	0.093	66.0	0.211	-100.5	14.7
600	0.488	165.6	3.858	73.2	0.108	66.2	0.212	-105.1	13.1
700	0.511	159.7	3.356	68.7	0.124	65.8	0.217	-108.3	12.0
800	0.507	153.1	2.937	64.2	0.138	66.5	0.223	-111.7	10.9
900	0.521	147.9	2.643	60.4	0.156	66.1	0.229	-114.9	10.1
1000	0.526	142.5	2.364	56.4	0.172	65.3	0.237	-118.5	9.1
1200	0.554	133.2	2.041	49.9	0.203	63.5	0.254	-127.3	8.1
1400	0.549	125.2	1.760	42.5	0.229	61.7	0.281	-136.1	6.8
1600	0.578	118.3	1.552	36.3	0.263	60.1	0.315	-142.3	6.0
1800	0.580	109.9	1.403	30.5	0.292	56.7	0.344	-148.6	5.3
2000	0.613	100.8	1.302	25.5	0.322	54.6	0.363	-154.8	5.0

Table 2 Common emitter scattering parameters,  $I_C = 100 \text{ mA}$ ;  $V_{CE} = 10 \text{ V}$ 

	S	11	S	21	s	12	S	22	G <sub>UM</sub>
www.bataSh	MAG. eet4(HAT)	ANG. (DEG)	MAG. (RAT)	ANG. (DEG)	MAG. (RAT)	ANG. (DEG)	MAG. (RAT)	ANG. (DEG)	(dB)
40	0.463	-74.1	33.964	141.6	0.020	64.0	0.786	-37.5	35.8
100	0.475	-126.8	20.065	115.5	0.033	58.0	0.481	-64.3	28.3
200	0.484	-156.8	11.112	98.0	0.048	57.9	0.294	82.6	22.5
300	0.479	-173.0	7.528	89.3	0.062	61.6	0.230	-92.9	18.9
400	0.494	177.7	5.729	82.6	0.079	64.5	0.210	-99.6	16.6
500	0.487	172.5	4.642	77.2	0.094	65.6	0.204	-105.5	14.7
600	0.487	164.6	3.896	73.1	0.110	66.5	0.205	-110.0	13.2
700	0.503	159.6	3.382	68.7	0.127	66.0	0.210	-113.1	12.0
800	0.506	151.9	2.965	64.1	0.141	66.1	0.216	<b>-116.1</b>	10.9
900	0.512	148.2	2.667	60.5	0.159	65.2	0.221	-119.3	10.1
1000	0.525	142.8	2.384	56.6	0.174	64.7	0.228	-122.5	9.2
1200	0.544	133.5	2.069	50.4	0.205	62.8	0.245	-131.4	8.1
1400	0.555	124.4	1.773	42.8	0.232	61.1	0.273	-139.3	6.9
1600	0.579	117.7	1.578	36.7	0.264	59.3	0.307	-145.3	6.2
1800	0.587	110.0	1.434	31.1	0.293	55.8	0.332	-151.1	5.5
2000	0.617	101.6	1.310	26.5	0.322	53.5	0.353	-157.1	5.0